

CORINTIS HARDWARE

THERMINATOR & TTV CORINTIS THERMAL TEST AND
VALIDATION INSTRUMENTS
FOR DATA CENTER COOLING

# Accelerate thermal testing with Therminator



The Therminator is a benchtop testing device for rapid pre-silicon thermal testing and cooling validation. It emulates the thermal behavior of an integrated circuit (IC) by using a physically similar test vehicle (TTV), allowing engineers to validate their cooling solutions.

DESCRIPTION

The Therminator uses spatial power density information from the powermap to control the array of heating elements on the Thermal test chip (TTC) to emulate the thermal characteristics of the IC chip. Temperature sensors in each heating element on the TTC measure the local junction temperature of the chip to provide a real-time heatmap of the chip surface. A cooling device, of the user's choice, is mounted on the TTV to cool the TTC down.

The powermap of the IC chip under test is uploaded to the device through the Display unit (DU). The control software allows the user to run several tests, cycle through various power maps, or run transient experiments. User can select multiple RTDs to compare them on the plot and save the data. Test results can be exported in standard, portable formats (CSV) and analyzed with common open-source packages.

PHYSICAL OVERVIEW

Length: 428 mm Width: 300 mm Height: 143 mm

Weight: 11 kg Color: Black

Material: Anodized aluminum

#### TECHNICAL OVERVIEW

Current range: 50 A
DC power capacity: 2000W\*
Output voltage: 48 V

Input voltage supply: 90-264 V(AC)

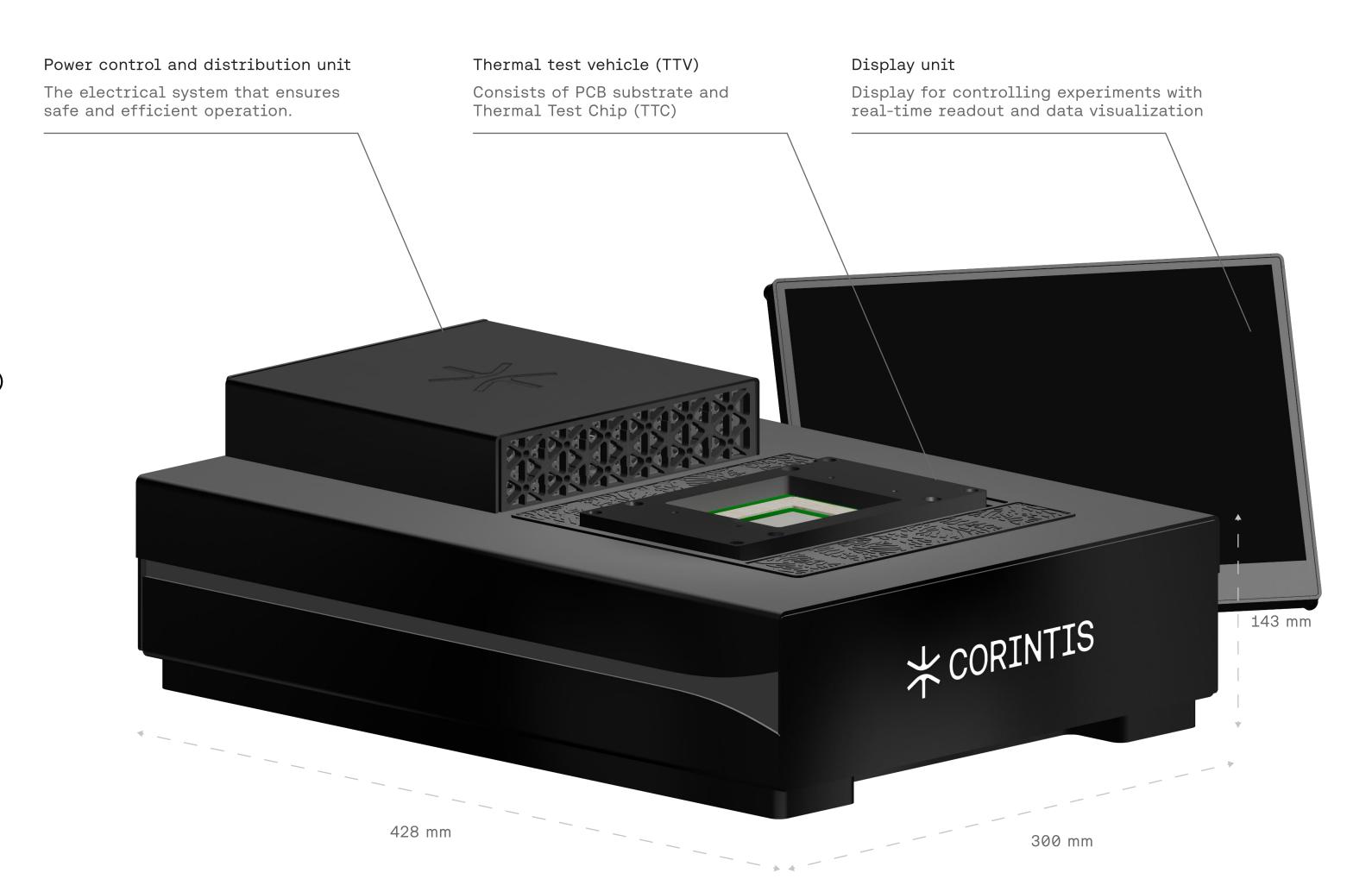
### DISPLAY OVERVIEW

Screen size: 13.3 inch Operating system: Linux Display: IPS touch Resolution: 1920x1080

### REQUIREMENTS

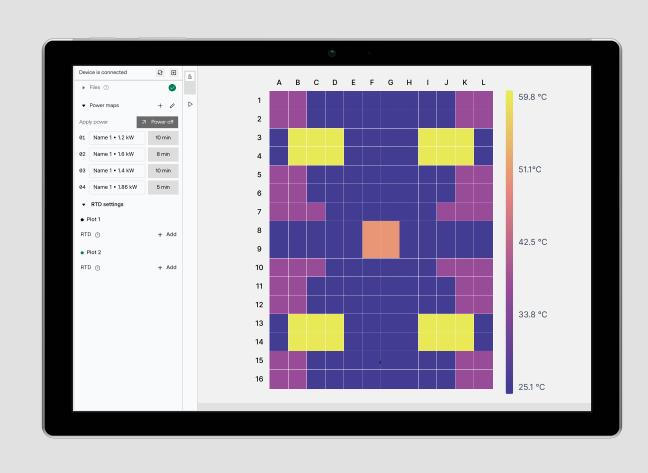
The device is powered by plugging into the power grid through 2x single-phase power cable, one each for two power supply units.

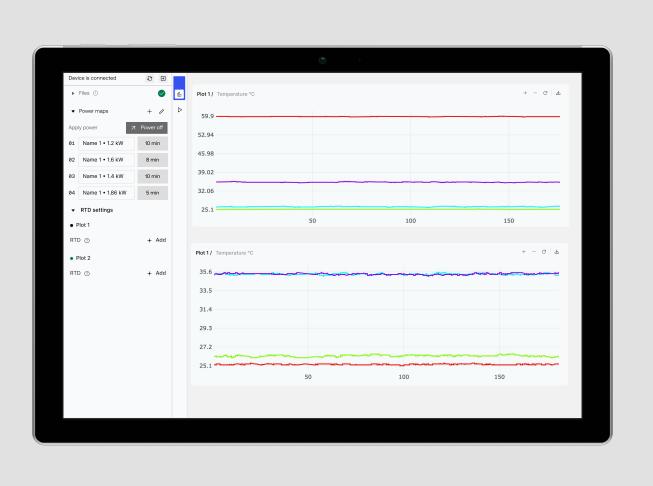
It is required by the client to have each power cable plugged into a different power grid socket line to not trip the circuit breaker.



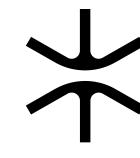
### **Experiment control**

- Load cell map & TTV calibration files to define sensor layout and ensure accurate temperature data.
- Apply multiple power maps with custom time ranges to simulate static & transient heating scenarios.
- Select RTDs for side-by-side comparison using live plots.
- Record & save the experiment data at any moment for later review.





# Mimic any power distribution on the chip with TTVs



The Thermal Test Vehicle is a Chip-on-Board package, which hosts a single full-reticle-sized Thermal Test Chip. The TTV package is based on Open Compute Project standard and utilizes their standards for electrical connectors and mounting points.

**DESCRIPTION** 

TTV package designed to simulate real processor behavior under thermal conditions. TTVs are used to test cooling solutions, validate thermal management systems, characterize TIM stability during power cycling, and calibrate measurement tools without relying on functional silicon. It consists of PCB substrate and Thermal Test Chip (TTC). The TTC implements a dense, tiled heating array designed to heterogeneous power maps typical of real emulate semiconductor dies.

Designed with flip-chip on low-CTE FR4 substrate and SAC305 solder, each TTV includes:

- 221 temperature sensing cells with 2x2 mm² resolution
- Support for up to 5 W/mm² heat flux
- Reliable performance up to 100 °C

Thermal Test Chip Silicon chip containing array of micro-heaters and temperature sensors



102 mm



PHYSICAL OVERVIEW

TTV Length: 165 mm TTV Width: 102 mm

TTC Length: 34 mm TTC Width: 26 mm

TECHNICAL OVERVIEW

Assembly technology: Flipchip on Substrate Substrate: Low CTE FR4 Solder type: SAC305

Solder bump diameter: 400 µm Mounting screws: M3.5 20

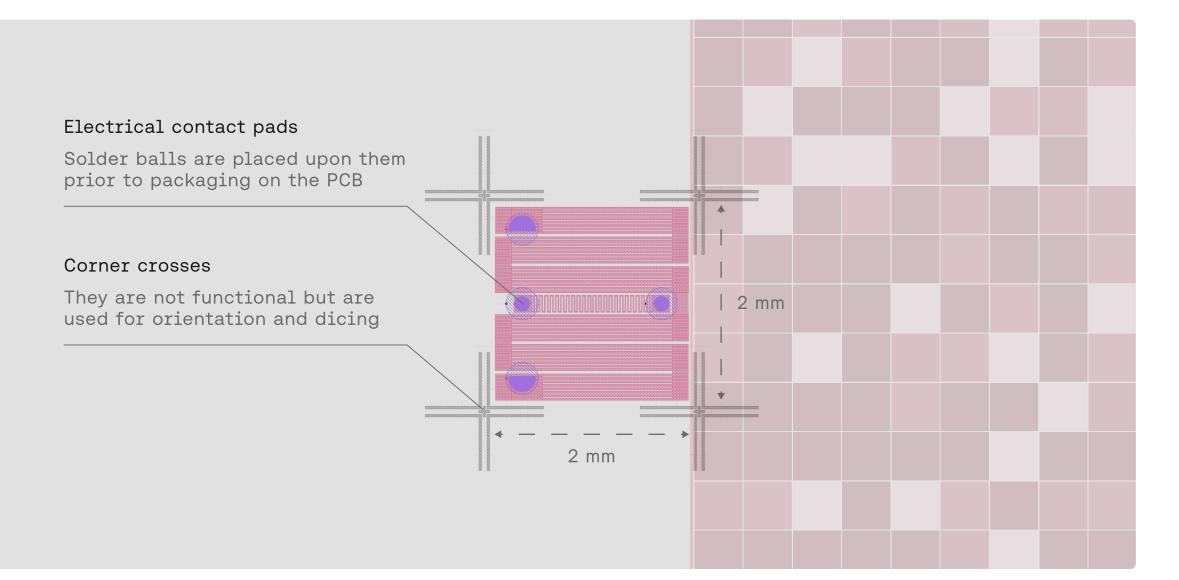
TTC Fabrication technology: Thin film TTC Temperature sensor: Resistance temp. detector Maximum operating temp.: 100 °C

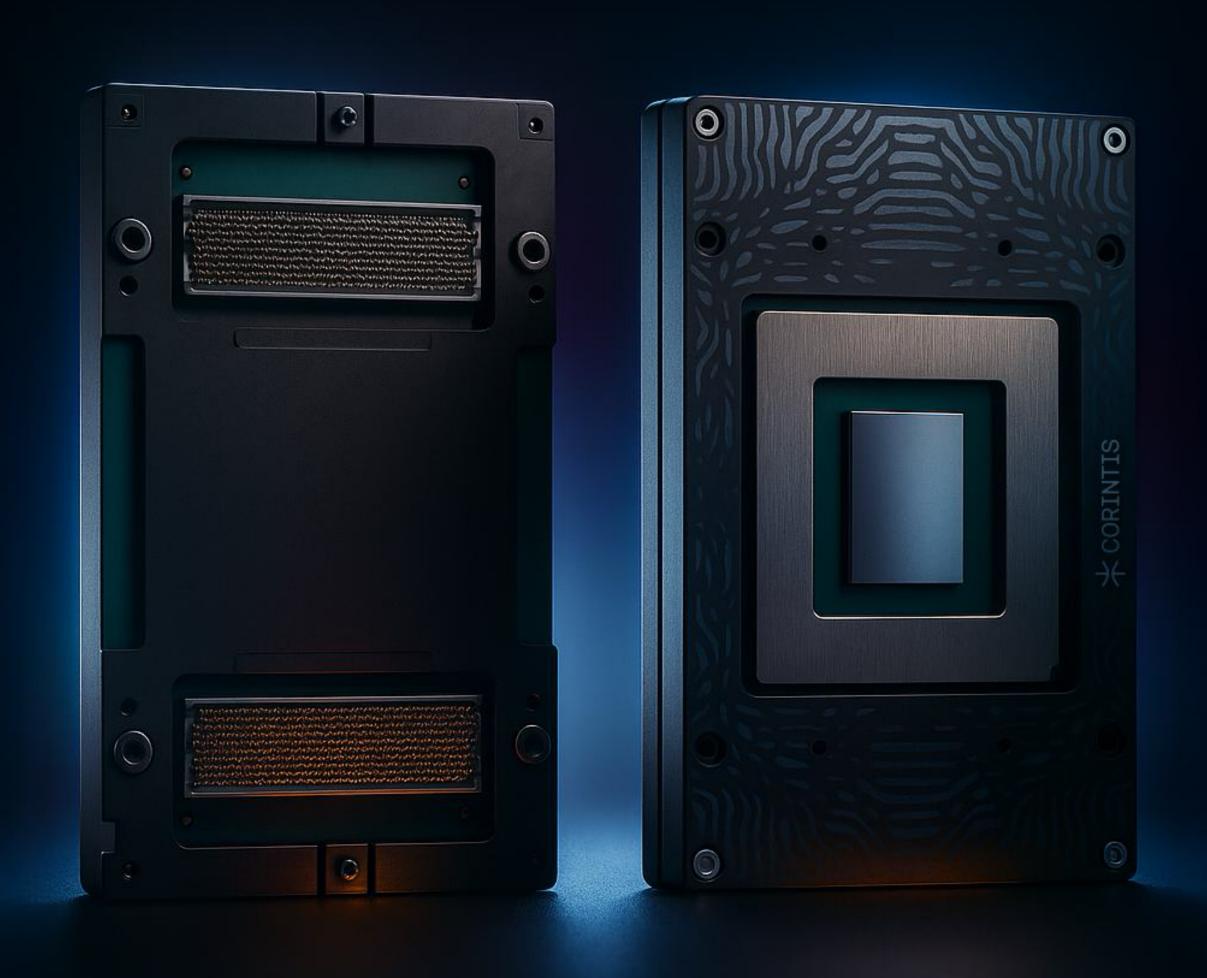
Maximum heat flux: 5 W/mm<sup>2</sup>

### Thermal cell configuration

- The TTC is composed of an array of 2 × 2 mm<sup>2</sup> cells laid out in a grid across the reticle-scale die.
- Each cell contains a thin-film resistive heater and an integrated temperature sensor for direct, local temperature measurement.
- Sensors are implemented as thin Temperature film Resistance with sub-degree Detectors resolution fast transient and response.

Number of cells: 221 total Cell size resolution:  $2 \times 2 \text{ mm}^2$ Resistance per cell: 100 Ω Thermally active cell area: 68%





Bottom and front view of TTV

# Contact

Let our application-engineering team help you design the optimal cooling solution for your application.

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## Website

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### Address

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